

**Notice of References Cited**

Application/Control No.

09/683,002

Applicant(s)/Patent Under  
Reexamination  
BASTIAENS ET AL.

Examiner

Rip A. Lee

Art Unit

1713

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*May 03, 2004*

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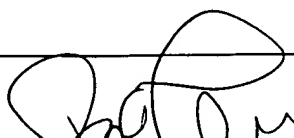

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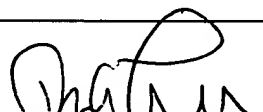
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